## 16 Megabit (2M x 8-Bit | 1M x 16-Bit) CMOS 3.0 Volt-Only Boot Sector Flash Memory

## **DISTINCTIVE CHARACTERISTICS**

#### **ARCHITECTURAL ADVANTAGES**

USTIN

Single Power Supply Operation – Full voltage range: 2.7 to 3.6 volt read and write operations for battery-powered applications

#### Manufactured on 110 nm Process Technology

• Fully compatible with 200 nm AS29LV016

#### Secured Silicon Sector region

- 128-word/256-byte sector for permanent, secure identification through an 8-word/16-byte random Electronic Serial Number accessible through a command sequence
- May be programmed and locked at the factory or by the customer

#### **Flexible Sector Architecture**

- One 16 Kbyte, two 8 Kbyte, one 32 Kbyte, and thirty-one 64 Kbyte sectors (byte mode)
- One 8 Kword, two 4 Kword, one 16 Kword, and thirty-one 32 Kword sectors (word mode)

#### Sector Group Protection Features

- A hardware method of locking a sector to prevent any program or erase operations within that sector
- · Sectors can be locked in-system or via programming equipment

 Temporary Sector Unprotect feature allows code changes in www.DataSheet4U.com previously locked sectors

#### **Unlock Bypass Program Command**

Reduces overall programming time when issuing multiple program command sequences

## Top or Bottom Boot Block Configurations Available Compatibility with JEDEC standards

- Pinout and software compatible with single-power supply Flash
- Superior inadvertent write protection

#### **PACKAGE OPTIONS**

• 48-pin TSOP

#### PERFORMANCE CHARACTERISTICS High Performance

- Access times as fast as 55 ns
- Extended temperature range (-40°C to +125°C) Military temperature range (-55°C to +125°C)

#### Ultra Low Power Consumption (typical values at 5 MHz)

- 0.2 µA Automatic Sleep mode current
- 0.2 µA standby mode current
- 7 mA read current
- 20 mA program/erase current

Cycling Endurance: 1,000,000 cycles per sector typical

#### Data Retention: 20 years typical

#### SOFTWARE FEATURES

#### CFI (Common Flash Interface) Compliant

 Provides device-specific information to the system, allowing host software to easily reconfigure for different Flash devices

#### Erase Suspend/Erase Resume

• Suspends an erase operation to read data from, or program data to, a sector that is not being erased, then resumes the erase operation

#### Data# Polling and Toggle Bits

Provides a software method of detecting program or erase operation completion  $% \left( {{{\left[ {{{\rm{c}}} \right]}}_{{\rm{c}}}}_{{\rm{c}}}} \right)$ 

#### HARDWARE FEATURES

#### Ready/Busy# Pin (RY/BY#)

Provides a hardware method of detecting program or erase cycle completion

#### Hardware Reset Pin (RESET#)

• Hardware method to reset the device to reading array data

#### WP# input pin

 For boot sector devices: at VIL, protects first or last 16 Kbyte sector depending on boot configuration (top boot or bottom boot)

## TIN Austin Semiconductor, Inc. COTS PEM Austin Semiconductor, Inc.

## **GENERAL DESCRIPTION**

The AS29LV016J is a 16 Mbit, 3.0 Volt-only Flash memory organized as 2,097,152 bytes or 1,048,576 words. The device is offered in a 48-pin TSOP package. The word-wide data (x16) appears on DQ15–DQ0; the byte-wide (x8) data appears on DQ7–DQ0. This device is designed to be programmed insystem with the standard system 3.0 volt Vcc supply. A 12.0 V VPP or 5.0 Vcc are not required for write or erase operations. The device can also be programmed in standard EPROM programmers.

The device offers access time of 55 ns allowing high speed microprocessors to operate without wait states. To eliminate bus contention the device has separate chip enable (CE#), write enable (WE#) and output enable (OE#) controls.

The device requires only a **single 3.0 volt power supply** for both read and write functions. Internally generated and regulated voltages are provided for the program and erase operations.

The AS29LV016J is entirely command set compatible with the **JEDEC single-power-supply Flash standard**. Commands are written to the command register using standard microprocessor write timings. Register contents serve as input to an internal state-machine that controls the erase and programming circuitry. Write cycles also internally latch addresses and data needed for the programming and erase operations. Reading data out of the device is similar to reading from other Flash or EPROM devices.

Device programming occurs by executing the program command sequence. This initiates the **Embedded Program** algorithm—an internal algorithm that automatically times the www.Dprogram<sup>4</sup> bulse widths and verifies proper cell margin. The **Unlock Bypass** mode facilitates faster programming times by requiring only two write cycles to program data instead of four.

Device erasure occurs by executing the erase command sequence. This initiates the **Embedded Erase** algorithm—an internal algorithm that automatically preprograms the array (if it is not already programmed) before executing the erase operation. During erase, the device automatically times the erase pulse widths and verifies proper cell margin.

The host system can detect whether a program or erase operation is complete by observing the RY/BY# pin, or by reading the DQ7 (Data# Polling) and DQ6 (toggle) **status bits**. After a program or erase cycle has been completed, the device is ready to read array data or accept another command.

The **sector erase architecture** allows memory sectors to be erased and reprogrammed without affecting the data contents of other sectors. The device is fully erased when shipped from the factory.

Hardware data protection measures include a low Vcc detector that automatically inhibits write operations during power transitions. The hardware sector protection feature disables both program and erase operations in any combination of the sectors of memory. This can be achieved in-system or via programming equipment.

The **Erase Suspend/Erase Resume** feature enables the user to put erase on hold for any period of time to read data from, or program data to, any sector that is not selected for erasure. True background erase can thus be achieved.

The **hardware RESET# pin** terminates any operation in progress and resets the internal state machine to reading array data. The RESET# pin may be tied to the system reset circuitry. A system reset would thus also reset the device, enabling the system microprocessor to read the boot-up firmware from the Flash memory.

The device offers two power-saving features. When addresses have been stable for a specified amount of time, the device enters the **automatic sleep mode**. The system can also place the device into the **standby mode**. Power consumption is greatly reduced in both these modes.

ASI combines years of flash memory manufacturing experience to produce the highest levels of quality, reliability and cost effectiveness. The device electrically erases all bits within a sector simultaneously via Fowler-Nordheim tunneling. The data is programmed using hot electron injection.

## COTS PEM **BOOT SECTOR FLASH**

Austin Semiconductor, Inc.

## AS29LV016J

## **PRODUCT SELECTOR GUIDE**

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**SEMICONDUCTOR** 

Family Part Numb	AS29LV016J		
Speed Option		70	
	Vcc =3.0-3.6V	55	
Max access time, i	ns (t <sub>ACC</sub> )	55	70
Max CE# access ti	55	70	
Max OE# access t	55	70	

Note: See AC Characteristics on page 29 for full specifications

## **BLOCK DIAGRAM**



## COTS PEM BOOT SECTOR FLASH

Austin Semiconductor, Inc.

## AS29LV016J

16 or 8

## PIN CONFIGURATION

**SEMICONDUCTOR** 

USTIN

A0A19 DQ0DQ14 DQ15/A-1	= = =	20 addresses 15 data inputs/outputs DQ15 (data input/output, word mode), A-1 (LSB address input, byte mode)
BYTE#	=	Selects 8-bit or 16-bit mode
CE#	=	Chip enable
OE#	=	Output enable
WE#	=	Write enable
WP#	=	Write protect: The WP# contains an
		internal pull-up; when unconnected, WP is at $V_{\mu}$
RESET#	=	
RY/BY#	=	Ready/Busy output
V <sub>cc</sub>	=	3.0 volt-only single power supply (see
		Product Selector Guide for speed
		options and voltage supply tolerances)
V <sub>ss</sub>	=	Device ground
NĈ	=	Pin not connected internally

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## **CONNECTION DIAGRAMS**



## **ORDERING INFORMATION**

USTIN

**SEMICONDUCTOR** 

Pb-BASED LEAD FINIS	H OPTION		
AS29LV016JTRG-55/IT	TOP BOOT	TSOP1-48	ENHANCED
AS29LV016JBRG-55/IT	<b>BOTTOM BOOT</b>	TSOP1-48	ENHANCED
AS29LV016JTRG-70/IT	TOP BOOT	TSOP1-48	ENHANCED
AS29LV016JBRG-70/IT	<b>BOTTOM BOOT</b>	TSOP1-48	ENHANCED
AS29LV016JTRG-55/ET	TOP BOOT	TSOP1-48	ENHANCED
AS29LV016JBRG-55/ET	<b>BOTTOM BOOT</b>	TSOP1-48	ENHANCED
AS29LV016JTRG-70/ET	TOP BOOT	TSOP1-48	ENHANCED
AS29LV016JBRG-70/ET	<b>BOTTOM BOOT</b>	TSOP1-48	ENHANCED
AS29LV016JTRG-55/XT	TOP BOOT	TSOP1-48	ENHANCED
AS29LV016JBRG-55/XT	<b>BOTTOM BOOT</b>	TSOP1-48	ENHANCED
AS29LV016JTRG-70/XT	TOP BOOT	TSOP1-48	ENHANCED
AS29LV016JBRG-70/XT	<b>BOTTOM BOOT</b>	TSOP1-48	ENHANCED
Pb-FREE LEAD FINISH	OPTION		
AS29LV016JTRGR-55/IT	TOP BOOT	TSOP1-48	ENHANCED
AS29LV016JBRGR-55/I7	BOTTOM BOOT	TSOP1-48	ENHANCED
AS29LV016JTRGR-70/IT	TOP BOOT	TSOP1-48	ENHANCED
AS29LV016JBRGR-70/I7	BOTTOM BOOT	TSOP1-48	ENHANCED
AS29LV016JTRGR-55/E	T TOP BOOT	TSOP1-48	ENHANCED
AS29LV016JBRGR-55/E	T BOTTOM BOOT	TSOP1-48	ENHANCED
AS29LV016JTRGR-70/E	T TOP BOOT	TSOP1-48	ENHANCED
AS29LV016JBRGR-70/E	T BOTTOM BOOT	TSOP1-48	ENHANCED
AS29LV016JTRGR-55/X	T TOP BOOT	TSOP1-48	ENHANCED

AS29LV016JTRGR-55/XT	TOP BOOT	TSOP1-48
AS29LV016JBRGR-55/XT	BOTTOM BOOT	TSOP1-48
AS29LV016JTRGR-70/XT	TOP BOOT	TSOP1-48
AS29LV016JBRGR-70/XT	BOTTOM BOOT	TSOP1-48

TAPE / REEL OPTION (specify on purchase order)

## \*AVAILABLE PROCESSES

IT = Industrial Temperature Range  $-40^{\circ}$ C to  $+85^{\circ}$ C ET = Extended Temperature Range  $-55^{\circ}$ C to  $+125^{\circ}$ C XT = Full Military Processing  $-55^{\circ}$ C to  $+125^{\circ}$ C ENHANCED ENHANCED ENHANCED



## **DEVICE BUS OPERATIONS**

This section describes the requirements and use of the device bus operations, which are initiated through the internal command register. The command register itself does not occupy any addressable memory location. The register is composed of latches that store the commands, along with the address and data information needed to execute the command. The contents of the register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device. Table 1 lists the device bus operations, the inputs and control levels they require, and the resulting output. The following subsections describe each of these operations in further detail.

#### Table 1: AS29LV016J Device Bus Operations

									DQ8-DQ15
							DQ0-	BYTE#	BYTE#
Operation	CE#	OE#	WE#	RESET#	WP#	Address <sup>1</sup>	DQ7	=V <sub>IH</sub>	=V <sub>IL</sub>
Read	L	L	Н	Н	Х	A <sub>IN</sub>	D <sub>OUT</sub>	D <sub>OUT</sub>	DQ8-DQ14= High Z,
Write	L	Н	L	Н	(Note 3)	A <sub>IN</sub>	(Note 4)	(Note 4)	DQ15=A-1
Standby	Vcc ± 0.3V	Х	Х	Vcc ± 0.3V	Х	Х	High-Z	High-Z	High-Z
Output Disable	L	Н	Н	Н	Х	Х	High-Z	High-Z	High-Z
Reset	Х	Х	Х	L	Х	Х	High-Z	High-Z	High-Z
Sector Protect <sup>2,3</sup>	L	Н	L	V <sub>ID</sub>		Sector Address, A6=L, A1=H, A0=L	(Note 4)	х	х
Sector Unprotect <sup>2.3</sup>	L	Н	L	V <sub>ID</sub>	Н	Sector Address, A6=H, A3=A2=L, A1=H, A0=L	(Note 4)	х	х
Temporary Sector Unprotect	Х	Х	Х	V <sub>ID</sub>		A <sub>IN</sub>	(Note 4)	(Note 4)	High-Z

#### Legend:

L= Logic Low = V<sub>IL</sub>, H=Logic High=V<sub>IH</sub>, V<sub>ID</sub>=12.0±0.5V, X=Don't Care, A<sub>IN</sub>=Address In, D<sub>IN</sub> = Data In, D<sub>OUT</sub>=Data Out

#### Notes:

1. Addresses are A19:A0 in word mode (BYTE# =  $V_{IH}$ ), A19:A-1 in byte mode (BYTE# =  $V_{II}$ )

2. The sector protect and sector unprotect functions may also be implemented via programming equipment. See Sector Protection / Unprotection on page 11.

3. If WP# = VIL, the outermost sector remains protected (determined by device configuration). If WP# = VIH, the outermost sector protection

www.Datadepends on whether the sector was last protected or unprotected using the method described in Section 7.10, Sector Group Protection/ Unprotection on page 21. The WP# contains an internal pull-up; when unconnected, WP is at VIH.

In the work contains an internal pull-up; when unconnected, we is at viri.
 DIN or DOUT as required by command sequence, data polling, or sector group protection algorithm.

## WORD / BYTE CONFIGURATION

The BYTE# pin controls whether the device data I/O pins DQ15–DQ0 operate in the byte or word configuration. If the BYTE# pin is set at logic 1, the device is in word configuration, DQ15–DQ0 are active and controlled by CE# and OE#.

If the BYTE# pin is set at logic 0, the device is in byte configuration, and only data I/O pins DQ0–DQ7 are active and controlled by CE# and OE#. The data I/O pins DQ8–DQ14 are tri-stated, and the DQ15 pin is used as an input for the LSB (A-1) address function.

## STIN Austin Semiconductor, Inc. COTS PEM AS29LV016J

## REQUIREMENTS FOR READING ARRAY DATA

To read array data from the outputs, the system must drive the CE# and OE# pins to  $V_{IL}$ . CE# is the power control and selects the device. OE# is the output control and gates array data to the output pins. WE# should remain at  $V_{IH}$ . The BYTE# pin determines whether the device outputs array data in words or bytes.

The internal state machine is set for reading array data upon device power-up, or after a hardware reset. This ensures that no spurious alteration of the memory content occurs during the power transition. No command is necessary in this mode to obtain array data. Standard microprocessor read cycles that assert valid addresses on the device address inputs produce valid data on the device data outputs. The device remains enabled for read access until the command register contents are altered.

See Reading Array Data on page 17 for more information. Refer to the AC Read Operations on page 29 for timing specifications and to Figure 12, on page 29 for the timing diagram.  $I_{CC1}$  in the DC Characteristics table represents the active current specification for reading array data.

## WRITING COMMANDS / COMMAND SEQUENCES

To write a command or command sequence (which www.Dincludes.programming data to the device and erasing sectors of memory), the system must drive WE# and CE# to V<sub>IL</sub>, and OE# to V<sub>IH</sub>.

For program operations, the BYTE# pin determines whether the device accepts program data in bytes or words. See Word Byte Configuration on page 6 for more information.

The device features an **Unlock Bypass** mode to facilitate faster programming. Once the device enters the Unlock Bypass mode, only two write cycles are required to program a word or byte, instead of four. Word Byte Program Command Sequence on page 18 has details on programming data to the device using both standard and Unlock Bypass command sequences. An erase operation can erase one sector, multiple sectors, or the entire device. Table 2 on page 9 and Table 3 on page 10 indicate the address space that each sector occupies. A "sector address" consists of the address bits required to uniquely select a sector. The Command Definitions on page 17 has details on erasing a sector or the entire chip, or suspending/resuming the erase operation.

After the system writes the autoselect command sequence, the device enters the autoselect mode. The system can then read autoselect codes from the internal register (which is separate from the memory array) on DQ7–DQ0. Standard read cycle timings apply in this mode. Refer to Autoselect Mode on page 11 and Autoselect Command Sequence on page 17 for more information.

 $I_{_{CC2}}$  in the DC Characteristics table represents the active current specification for the write mode. AC Characteristics on page 29 contains timing specification tables and timing diagrams for write operations.

## PROGRAM AND ERASE OPERATION STATUS

During an erase or program operation, the system may check the status of the operation by reading the status bits on DQ7–DQ0. Standard read cycle timings and  $I_{cc}$ read specifications apply. Refer to Write Operation Status on page 22 for more information, and to AC Characteristics on page 29 for timing diagrams.

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## STANDBY MODE

When the system is not reading or writing to the device, it can place the device in the standby mode. In this mode, current consumption is greatly reduced, and the outputs are placed in the high impedance state, independent of the OE# input.

The device enters the CMOS standby mode when the CE# and RESET# pins are both held at  $V_{cc} \pm 0.3$  V. (Note that this is a more restricted voltage range than  $V_{IH}$ .) If CE# and RESET# are held at  $V_{IH}$ , but not within  $V_{cc} \pm 0.3$  V, the device will be in the standby mode, but the standby current will be greater. The device requires standard access time ( $t_{cE}$ ) for read access when the device is in either of these standby modes, before it is ready to read data.

If the device is deselected during erasure or programming, the device draws active current until the operation is completed.

 $\rm I_{\rm CC3}$  and  $\rm I_{\rm CC4}$  represents the standby current specification shown in the table in DC Characteristics on page 27.

## AUTOMATIC SLEEP MODE

The automatic sleep mode minimizes Flash device energy consumption. The device automatically enables this mode when addresses remain stable for t<sub>ACC</sub> + 30 ns. The automatic sleep mode is independent of the CE#, WE#, and OE# control signals. Standard address access timings provide new data when addresses are changed. While in sleep mode, output data is latched and always available to the system. I<sub>CC4</sub> in the DC Characteristics on page 27 represents the automatic sleep mode current specification.

## **RESET#: HARDWARE RESET PIN**

The RESET# pin provides a hardware method of resetting the device to reading array data. When the system drives the RESET# pin to  $V_{IL}$  for at least a period of  $t_{RP}$ , the device **immediately terminates** any operation in progress, tristates all data output pins, and ignores all read/write attempts for the duration of the RESET# pulse. The device also resets the internal state machine to reading array data. The operation that was interrupted should be reinitiated once the device is ready to accept another command sequence, to ensure data integrity.

Current is reduced for the duration of the RESET# pulse. When RESET# is held at V<sub>ss</sub>±0.3 V, the device draws CMOS standby current (I<sub>CC4</sub>). If RESET# is held at V<sub>IL</sub> but not within V<sub>ss</sub>±0.3 V, the standby current will be greater.

The RESET# pin may be tied to the system reset circuitry. A system reset would thus also reset the Flash memory, enabling the system to read the boot-up firmware from the Flash memory.

If RESET# is asserted during a program or erase operation, the RY/BY# pin remains a *O* (busy) until the internal reset operation is complete, which requires a time of  $t_{READY}$  (during Embedded Algorithms). The system can thus monitor RY/BY# to determine whether the reset operation is complete. If RESET# is asserted when a program or erase operation is not executing (RY/BY# pin is *1*), the reset operation is completed within a time of  $t_{READY}$  (not during Embedded Algorithms). The system can read data  $t_{RH}$  after the RESET# pin returns to  $V_{IH}$ .Refer to the tables in AC Characteristics on page 29 for RESET# parameters and to Figure 13, on page 30 for the timing diagram.



#### OUTPUT DISABLE MODE

When the OE# input is at  $V_{H}$ , output from the device is disabled. The output pins are placed in the high impedance state.

#### Table 2: Sector Address Tables (Top Boot Device)

ector           SA0           SA1           SA2           SA3           SA3           SA4           SA5           SA6           SA7           SA8           SA8	A19 0 0 0 0 0 0 0 0 0 0 0 0 0	A18 0 0 0 0 0 0 0 0 0 0	A17 0 0 0 1 1 1	A16 0 1 1 0 0	A15 0 1 0 1 0	A14 X X X X X X	A13 X X X X X	A12 X X X	(Kbytes / Kwords) 64/32 64/32 64/32	Byte Mode (x8) 000000-00FFFF 010000-01FFFF 020000-02FFFF	Word Mode (x16) 00000-07FFF 08000-0FFFF 10000-17FFF
SA1 SA2 SA3 SA4 SA5 SA6 SA6 SA7 SA8	0 0 0 0 0 0 0 0 0	0 0 0 0 0 0	0 0 1 1 1	0 1 1 0 0	1 0 1 0	X X X	X X	X X	64/32	010000-01FFFF	08000-0FFFF
SA2 SA3 SA4 SA5 SA6 SA7 SA8	0 0 0 0 0 0	0 0 0 0 0	0 0 1 1 1	1 1 0 0	0 1 0	X X	Х	Х			
SA3 SA4 SA5 SA6 SA7 SA8	0 0 0 0 0 0	0 0 0 0	0 1 1 1	1 0 0	1 0	Х			64/32	020000-02FFFF	10000-17EEE
SA4 SA5 SA6 SA7 SA8	0 0 0 0	0 0 0	1 1 1	0 0	0		Х				10000-1711-F
SA5 SA6 SA7 SA8	0 0 0	0	1 1	0	-	Х		Х	64/32	030000-03FFFF	18000-1FFFF
SA6 SA7 SA8	0 0	0	1		4		Х	Х	64/32	040000-04FFFF	20000-27FFF
SA7 SA8	0	-		4	1	Х	Х	Х	64/32	050000-05FFFF	28000-2FFFF
SA8	-	0		1	0	Х	Х	Х	64/32	060000-06FFFF	30000-37FFF
	0		1	1	1	Х	Х	Х	64/32	070000-07FFFF	38000-3FFFF
SA9		1	0	0	0	Х	Х	Х	64/32	080000-08FFFF	40000-47FFF
	0	1	0	0	1	Х	Х	Х	64/32	090000-09FFFF	48000-4FFFF
A10	0	1	0	1	0	Х	Х	Х	64/32	0A0000-0AFFFF	50000-57FFF
A11	0	1	0	1	1	Х	Х	Х	64/32	0B0000-0BFFFF	58000-5FFFF
A12	0	1	1	0	0	Х	Х	Х	64/32	0C0000-0CFFFF	60000-67FFF
A13	0	1	1	0	1	Х	Х	Х	64/32	0D0000-0DFFFF	68000-6FFFF
A14	0	1	1	1	0	Х	Х	Х	64/32	0E0000-0EFFFF	70000-77FFF
A15	0	1	1	1	1	Х	Х	Х	64/32	0F0000-0FFFFF	78000-7FFFF
A16	1	0	0	0	0	Х	Х	Х	64/32	100000-10FFFF	80000-87FFF
A17	1	0	0	0	1	Х	Х	Х	64/32	110000-11FFFF	88000-8FFFF
A18	1	0	0	1	0	Х	Х	Х	64/32	120000-12FFFF	90000-97FFF
A19	1	0	0	1	1	Х	Х	Х	64/32	130000-13FFFF	98000-9FFFF
A20	1	0	1	0	0	Х	Х	Х	64/32	140000-14FFFF	A0000-A7FFF
A21	1	0	1	0	1	Х	Х	Х	64/32	150000-15FFFF	A8000-AFFFF
A22	1	0	1	1	0	Х	Х	Х	64/32	160000-16FFFF	B0000-B7FFF
A23	1	0	1	1	1	Х	Х	Х	64/32	170000-17FFFF	B8000-BFFFF
A24	1	1	0	0	0	Х	Х	Х	64/32	180000-18FFFF	C0000-C7FFF
A25	U.com 1	1	0	0	1	Х	Х	Х	64/32	190000-19FFFF	C8000-CFFFF
A26	1	1	0	1	0	Х	Х	Х	64/32	1A0000-1AFFFF	D0000-D7FFF
A27	1	1	0	1	1	Х	Х	Х	64/32	1B0000-1BFFFF	D8000-DFFFF
A28	1	1	1	0	0	Х	Х	Х	64/32	1C0000-1CFFFF	E0000-E7FFF
A29	1	1	1	0	1	Х	Х	Х	64/32	1D0000-1DFFFF	E8000-EFFFF
A30	1	1	1	1	0	Х	Х	Х	64/32	1E0000-1EFFFF	F0000-F7FFF
A31	1	1	1	1	1	0	Х	Х	32/16	1F0000-1F7FFF	F8000-FBFFF
A32	1	1	1	1	1	1	0	0	8/4	1F8000-1F9FFF	FC000-FCFFF
A33	1	1	1	1	1	1	0	1	8/4	1FA000-1FBFFF	FD000-FDFFF
A34	1	1	1	1	1	1	1	Х	16/8	1FC000-1FFFFF	FE000-FFFFF
	A11       A12       A13       A14       A15       A16       A17       A18       A19       A20       A21       A22       A23       A24       A25       A26       A27       A28       A29       A30       A31       A32       A34	$\begin{array}{c ccccc} A11 & 0 \\ A12 & 0 \\ A13 & 0 \\ A13 & 0 \\ A14 & 0 \\ A15 & 0 \\ A16 & 1 \\ A17 & 1 \\ A18 & 1 \\ A17 & 1 \\ A18 & 1 \\ A19 & 1 \\ A19 & 1 \\ A20 & 1 \\ A21 & 1 \\ A22 & 1 \\ A23 & 1 \\ A30 & 1 \\ A31 & 1 \\ A32 & 1 \\ A33 & 1 \\ A34 & 1 \\ \end{array}$	A11         0         1           A12         0         1           A13         0         1           A13         0         1           A13         0         1           A14         0         1           A15         0         1           A16         1         0           A17         1         0           A18         1         0           A19         1         0           A20         1         0           A21         1         0           A22         1         0           A23         1         0           A24         1         1           A25         1         1           A26         1         1           A27         1         1           A30         1         1           A31         1         1           A33         1         1           A34         1         1	A11       0       1       0         A12       0       1       1         A13       0       1       1         A13       0       1       1         A13       0       1       1         A14       0       1       1         A15       0       1       1         A16       1       0       0         A17       1       0       0         A18       1       0       0         A19       1       0       1         A20       1       0       1         A21       1       0       1         A22       1       0       1         A23       1       0       1         A24       1       1       0         A27       1       1       0         A28       1       1       1         A30       1       1       1         A31       1       1       1         A33       1       1       1	A11       0       1       0       1         A12       0       1       1       0         A13       0       1       1       0         A13       0       1       1       0         A14       0       1       1       1         A15       0       1       1       1         A16       1       0       0       0         A17       1       0       0       1         A18       1       0       0       1         A19       1       0       1       0         A20       1       0       1       0         A21       1       0       1       1         A23       1       0       1       1         A23       1       0       1       1         A23       1       0       1       1         A24       1       1       0       1         A27       1       1       0       1         A30       1       1       1       1         A31       1       1       1       1	A1101011A1201100A1301101A1401110A1501111A1610000A1710011A1810011A1910011A2010110A2110111A2210111A2310111A2411001A2511011A2611011A2311110A2711011A3011111A3111111A3311111A3411111	A11         0         1         0         1         1         X           A12         0         1         1         0         0         X           A13         0         1         1         0         1         X           A13         0         1         1         0         1         X           A14         0         1         1         1         0         X           A14         0         1         1         1         0         X           A14         0         1         1         1         X         X           A15         0         1         1         1         X         X           A15         0         1         1         X         X         X           A16         1         0         0         1         X         X           A18         1         0         0         1         X         X           A20         1         0         1         0         X         X           A21         1         0         1         1         X         X           A22 <td< td=""><td>A11         0         1         0         1         1         X         X           A12         0         1         1         0         0         X         X           A13         0         1         1         0         1         X         X           A13         0         1         1         0         1         X         X           A14         0         1         1         1         0         X         X           A14         0         1         1         1         0         X         X           A15         0         1         1         1         X         X           A16         1         0         0         0         X         X           A17         1         0         0         1         X         X           A18         1         0         0         1         X         X           A20         1         0         1         0         X         X           A21         1         0         1         1         X         X           A22         1         0         1</td><td>A11         0         1         0         1         1         X         X         X           A12         0         1         1         0         0         X         X         X           A13         0         1         1         0         1         X         X         X           A13         0         1         1         0         1         X         X         X           A14         0         1         1         1         0         X         X         X           A15         0         1         1         1         1         X         X         X           A16         1         0         0         0         0         X         X         X           A17         1         0         0         1         X         X         X           A18         1         0         0         1         X         X         X           A20         1         0         1         0         X         X         X           A21         1         0         1         1         X         X         X</td><td>A11         0         1         0         1         1         X         X         X         64/32           A12         0         1         1         0         0         X         X         X         64/32           A13         0         1         1         0         1         X         X         X         64/32           A14         0         1         1         0         X         X         X         64/32           A14         0         1         1         1         0         X         X         X         64/32           A15         0         1         1         1         X         X         X         64/32           A16         1         0         0         0         X         X         X         64/32           A17         1         0         0         1         1         X         X         X         64/32           A18         1         0         0         1         1         X         X         X         64/32           A20         1         0         1         0         X         X         X</td><td>A11         0         1         0         1         1         X         X         X         64/32         0B000-0BFFF           A12         0         1         1         0         0         X         X         X         64/32         0C0000-0CFFF           A13         0         1         1         0         1         X         X         64/32         0D0000-0EFFF           A14         0         1         1         0         X         X         X         64/32         0E0000-0EFFF           A15         0         1         1         1         X         X         X         64/32         0F0000-0FFFF           A16         1         0         0         0         X         X         X         64/32         10000-1FFF           A17         1         0         0         1         X         X         K         64/32         120000-12FFF           A18         1         0         0         1         X         X         K         64/32         13000-13FFF           A20         1         0         1         0         X         X         K         64/32         1400</td></td<>	A11         0         1         0         1         1         X         X           A12         0         1         1         0         0         X         X           A13         0         1         1         0         1         X         X           A13         0         1         1         0         1         X         X           A14         0         1         1         1         0         X         X           A14         0         1         1         1         0         X         X           A15         0         1         1         1         X         X           A16         1         0         0         0         X         X           A17         1         0         0         1         X         X           A18         1         0         0         1         X         X           A20         1         0         1         0         X         X           A21         1         0         1         1         X         X           A22         1         0         1	A11         0         1         0         1         1         X         X         X           A12         0         1         1         0         0         X         X         X           A13         0         1         1         0         1         X         X         X           A13         0         1         1         0         1         X         X         X           A14         0         1         1         1         0         X         X         X           A15         0         1         1         1         1         X         X         X           A16         1         0         0         0         0         X         X         X           A17         1         0         0         1         X         X         X           A18         1         0         0         1         X         X         X           A20         1         0         1         0         X         X         X           A21         1         0         1         1         X         X         X	A11         0         1         0         1         1         X         X         X         64/32           A12         0         1         1         0         0         X         X         X         64/32           A13         0         1         1         0         1         X         X         X         64/32           A14         0         1         1         0         X         X         X         64/32           A14         0         1         1         1         0         X         X         X         64/32           A15         0         1         1         1         X         X         X         64/32           A16         1         0         0         0         X         X         X         64/32           A17         1         0         0         1         1         X         X         X         64/32           A18         1         0         0         1         1         X         X         X         64/32           A20         1         0         1         0         X         X         X	A11         0         1         0         1         1         X         X         X         64/32         0B000-0BFFF           A12         0         1         1         0         0         X         X         X         64/32         0C0000-0CFFF           A13         0         1         1         0         1         X         X         64/32         0D0000-0EFFF           A14         0         1         1         0         X         X         X         64/32         0E0000-0EFFF           A15         0         1         1         1         X         X         X         64/32         0F0000-0FFFF           A16         1         0         0         0         X         X         X         64/32         10000-1FFF           A17         1         0         0         1         X         X         K         64/32         120000-12FFF           A18         1         0         0         1         X         X         K         64/32         13000-13FFF           A20         1         0         1         0         X         X         K         64/32         1400

Note: Address range is A19:A-1 in byte mode and A19:A0 in word mode. See Word/Byte Configuration on page 6.

#### Table 3: Sector Address Tables (Bottom Boot Device)

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**SEMICONDUCTOR** 

									Sector Size	Address Range	(in hexadecimal)
Sector	A19	A18	A17	A16	A15	A14	A13	A12	(Kbytes / Kwords)	Byte Mode (x8)	Word Mode (x16)
SA0	0	0	0	0	0	0	0	Х	16/8	000000-003FFF	00000-01FFF
SA1	0	0	0	0	0	0	1	0	8/4	004000-005FFF	02000-02FFF
SA2	0	0	0	0	0	0	1	1	8/4	006000-007FFF	03000-03FFF
SA3	0	0	0	0	0	1	Х	Х	32/16	008000-00FFFF	04000-04FFF
SA4	0	0	0	0	1	Х	Х	Х	64/32	010000-01FFFF	08000-0FFFF
SA5	0	0	0	1	0	Х	Х	Х	64/32	020000-02FFFF	10000-17FFF
SA6	0	0	0	1	1	Х	Х	Х	64/32	030000-03FFFF	18000-1FFFF
SA7	0	0	1	0	0	Х	Х	Х	64/32	040000-04FFFF	20000-27FFF
SA8	0	0	1	0	1	Х	Х	Х	64/32	050000-05FFFF	28000-2FFFF
SA9	0	0	1	1	0	Х	Х	Х	64/32	060000-06FFFF	30000-37FFF
SA10	0	0	1	1	1	Х	Х	Х	64/32	070000-07FFFF	38000-3FFFF
SA11	0	1	0	0	0	Х	Х	Х	64/32	080000-08FFFF	40000-47FFF
SA12	0	1	0	0	1	Х	Х	Х	64/32	090000-09FFFF	48000-4FFFF
SA13	0	1	0	1	0	Х	Х	Х	64/32	0A0000-0AFFFF	50000-57FFF
SA14	0	1	0	1	1	Х	Х	Х	64/32	0B0000-0BFFFF	58000-5FFFF
SA15	0	1	1	0	0	Х	Х	Х	64/32	0C0000-0CFFFF	60000-67FFF
SA16	0	1	1	0	1	Х	Х	Х	64/32	0D0000-0DFFFF	68000-6FFFF
SA17	0	1	1	1	0	Х	Х	Х	64/32	0E0000-0EFFFF	70000-77FFF
SA18	0	1	1	1	1	Х	Х	Х	64/32	0F0000-0FFFFF	78000-7FFFF
SA19	1	0	0	0	0	Х	Х	Х	64/32	100000-10FFFF	80000-87FFF
SA20	1	0	0	0	1	Х	Х	Х	64/32	110000-11FFFF	88000-8FFFF
SA21	1	0	0	1	0	Х	Х	Х	64/32	120000-12FFFF	90000-97FFF
SA22	1	0	0	1	1	Х	Х	Х	64/32	130000-13FFFF	98000-9FFFF
SA23	1	0	1	0	0	Х	Х	Х	64/32	140000-14FFFF	A0000-A7FFF
SA24	1	0	1	0	1	Х	Х	Х	64/32	150000-15FFFF	A8000-AFFFF
SA25	1	0	1	1	0	Х	Х	Х	64/32	160000-16FFFF	B0000-B7FFF
SA26	1	0	1	1	1	Х	Х	Х	64/32	170000-17FFFF	B8000-BFFFF
SA27	1	1	0	0	0	Х	Х	Х	64/32	180000-18FFFF	C0000-C7FFF
SA28	1	1	0	0	1	Х	Х	Х	64/32	190000-19FFFF	C8000-CFFFF
SA29	1	1	0	1	0	Х	Х	Х	64/32	1A0000-1AFFFF	D0000-D7FFF
ata <b>SA30</b> et4	U.com	1	0	1	1	Х	Х	Х	64/32	1B0000-1BFFFF	D8000-DFFFF
SA31	1	1	1	0	0	Х	Х	Х	64/32	1C0000-1CFFFF	E0000-E7FFF
SA32	1	1	1	0	1	Х	Х	Х	64/32	1D0000-1DFFFF	E8000-EFFFF
SA33	1	1	1	1	0	Х	Х	Х	64/32	1E0000-1EFFFF	F0000-F7FFF
SA34	1	1	1	1	1	Х	Х	Х	64/32	1F0000-1FFFFF	F8000-FFFFF

Note: Address range is A19:A-1 in byte mode and A19:A0 in word mode. See Word/Byte Configuration on page 6.

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### AUTOSELECT MODE

The autoselect mode provides manufacturer and device identification, and sector protection verification, through identifier codes output on DQ7–DQ0. This mode is primarily intended for programming equipment to automatically match a device to be programmed with its corresponding programming algorithm. However, the autoselect codes can also be accessed in-system through the command register.

When using programming equipment, the autoselect mode requires  $V_{ID}$  (11.5 V to 12.5 V) on address pin A9. Address pins A6, A1, and A0 must be as shown in Table 4 below.

In addition, when verifying sector protection, the sector address must appear on the appropriate highest order address bits (see Table 2 on page 9 and Table 3 on page 10). Table 4, immediately below, shows the remaining address bits that are don't care. When all necessary bits have been set as required, the programming equipment may then read the corresponding identifier code on DQ7-DQ0.

To access the autoselect codes in-system, the host system can issue the autoselect command via the command register, as shown in Table 9 on page 21. This method does not require VID. See Command Definitions on page 17 for details on using the autoselect mode.

#### Table 4: AS29LV016J Autoselect Codes (High Voltage Method)

Description	Mode	CE#	OE#	WE#	A19 to A10	A9	A8 to A7	A6	A5 to A4	A3 to A2	A1	A0	DQ8 to DQ15	DQ7 to DQ0
Manufacturer ID: Spansion		L	L	Н	Х	V <sub>ID</sub>	Х	L	Х	L	L	L	Х	01h
Device ID: S29AL016J	Word	L	L	Н	v	VID	х	1	v	1		н	22h	C4h
(Top Boot Block)	Byte	L	L	Н	^	v ID	^	L	^	L	L	п	Х	C4h
Device ID: S29AL016DJ	Word	L	L	Н	Y	VID	×	1	×	1		н	22h	49h
(Bottom Boot Block)	Byte	L	L	н	^	▼ ID	^	L	^	L	L		Х	49h
Sector Protection Verification		-	-	н	SA	VID	х	1	×	1	н	-	Х	01h (protected)
Sector Protection Vernication	1	L	Ŀ		34	¥ ID	^ L		^	L			Х	00h (unprotected)

L= Logic Low = V<sub>IL</sub>, H=Logic High=V<sub>IH</sub>, SA = Sector Address, X=Don't Care

Note: The autoselect codes may also be accessed in-system via command sequences. See Table 9 on page 21.

## **SECTOR PROTECTION / UNPROTECTION**

www.<sup>D</sup>The hardware sector group protection feature disables both program and erase operations in any sector group (see Table 2 on page 9 to Table 4 on page 11). The hardware sector group unprotection feature re-enables both program and erase operations in previously protected sector groups. Sector group protection/unprotection can be implemented via two methods.

Sector protection/unprotection requires VID on the RESET# pin only, and can be implemented either insystem or via programming equipment. Figure 2 on page 13 shows the algorithms and Figure 22 on page 36 shows the timing diagram. This method uses standard microprocessor bus cycle timing. For sector group unprotect, all unprotected sector groups must first be protected prior to the first sector group unprotect write cycle.

The device is shipped with all sector groups unprotected. ASI offers the option of programming and protecting sector groups at its factory prior to shipping the device through ASI Programming Service. Contact an ASI representative for details.

It is possible to determine whether a sector group is protected or unprotected. See *Autoselect Mode* above for details.



## **TEMPORARY SECTOR UNPROTECT**

This feature allows temporary unprotection of previously protected sectors to change data in-system. The Sector Unprotect mode is activated by setting the RESET# pin to  $V_{ID}$ . During this mode, formerly protected sectors can be programmed or erased by selecting the sector addresses. Once  $V_{ID}$  is removed from the RESET# pin, all the previously protected sectors are protected again. Figure 1 shows the algorithm, and Figure 21, on page 35 shows the timing diagrams, for this feature.



#### Notes:

1. All protected sectors unprotected.

2. All previously protected sectors are protected once again.

#### Figure I. Temporary Sector Unprotect Operation





## COMMON FLASH MEMORY INTERFACE (CFI)

The Common Flash Interface (CFI) specification outlines device and host system software interrogation handshake, which allows specific vendor-specified software algorithms to be used for entire families of devices. Software support can then be device-independent, JEDEC IDindependent, and forward- and backward-compatible for the specified flash device families. Flash vendors can standardize their existing interfaces for long-term compatibility.

This device enters the CFI Query mode when the system writes the CFI Query command, 98h, to address 55h in word mode (or address AAh in byte mode), any time the device is ready to read array data. The system can read CFI information at the addresses given in Tables 5–8. In word mode, the upper address bits (A7–MSB) must be all zeros. To terminate reading CFI data, the system must write the reset command.

The system can also write the CFI query command when the device is in the autoselect mode. The device enters the CFI query mode, and the system can read CFI data at the addresses given in Tables 5–8. The system must write the reset command to return the device to the autoselect mode.

## Table 5: CFI Query Identification String

. . .

	Addresses	Addresses		
	(Word Mode)	(Byte Mode)	Data	Description
	10h ataSheet4U.com 11h	20h	0051h	
VV VV VV.D	11h	22h	0052h	Query Unique ASCII String "QRY"
	12h	24h	0059h	
	13h	26h	0002h	Primary OEM Command Set
	14h	28h	0000h	Fillinary OEM Continiand Set
	15h	2Ah	0040h	Address for Primary Extended Table
	16h	2Ch	0000h	Address for Philliary Extended Table
	17h	2Eh	0000h	Alternate OEM Command Set (00h=none exists)
	18h	30h	0000h	Alternate OEM Command Set (0011-1011e exists)
	19h	32h	0000h	Address for Alternate OEM Extended Table (00b=pape existe)
	1Ah	34h	0000h	Address for Alternate OEM Extended Table (00h=none exists)

. . .

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## Table 6: System Interface String

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Addresses (Word Mode)	Addresses (Byte Mode)	Data	Description	
1Bh	36h	0027h	V <sub>CC</sub> Min. (write/erase) D7-D4:volt, D3-D0: 100 millivolt	
1Ch	38h	0036h	V <sub>CC</sub> Max. (write/erase) D7-D4:volt, D3-D0:100 millivolt	
1Dh	3Ah	0000h	V <sub>PP</sub> Min. voltage (00h=no V <sub>PP</sub> pin present)	
1Eh	3Ch	0000h	V <sub>PP</sub> Max. voltage (00h=no V <sub>PP</sub> pin present)	
1Fh	3Eh	0003h	Typical timeout per single byte/word write 2 <sup>N</sup> μs	
20h	40h	0000h	Typical timeout for Min. size buffer write $2^N \mu s$ (00h=not supported)	
21h	42h	0009h	Typical timeout per individual block erase 2 <sup>N</sup> ms	
22h	44h	0000h	Typical timeout for full chip erase 2 <sup>N</sup> ms (00h=not supported)	
23h	46h	0005h	Max. timeout for byte/word write 2 <sup>N</sup> times typical	
24h	48h	0000h	Max. timeout for buffer write 2 <sup>N</sup> times typical	
25h	4Ah	0004h	Max. timeout per individual block erase 2 <sup>N</sup> times typical	
26h	4Ch	0000h	Max. timeout for full chip erase 2 <sup>N</sup> times typical (00h=not supported)	

**Table 7: Device Geometry Definition** 

	Addresses (Word Mode)	Addresses (Byte Mode)	Data	Description
	27h	4Eh	0015h	Device Size = 2 <sup>N</sup> Byte
	28h	50h	0002h	Flash Device Interface description (refer to CFI publication 100)
	29h	52h	0000h	
	2Ah	54h	0000h	Max. number of byte in multi-byte write = $2^{N}$ (00h= not supported)
	2Bh	56h	0000h	Max. number of byte in multi-byte write – 2 (001– not supported)
www.Da	taShee <b>2Ch</b> com	58h	0004h	Number of Erase Block Regions within device
	2Dh	5Ah	0000h	
	2Eh	5Ch	0000h	Erase Block Region 1 Information
	2Fh	5Eh	0040h	(refer to the CFI specification or CFI publication 100)
	30h	60h	0000h	
	31h	62h	0001h	
	32h	64h	0000h	Erase Block Region 2 Information
	33h	66h	0020h	
	34h	68h	0000h	
	35h	6Ah	0000h	
	36h	6Ch	0000h	Erase Block Region 3 Information
	37h	6Eh	0080h	
	38h	70h	0000h	
	39h	72h	001Eh	
	3Ah	74h	0000h	Erase Block Region 4 Information
	3Bh	76h	0000h	
	3Ch	78h	0001h	

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## Table 8: Primary Vendor-Specific Extended Query

Addresses (Word Mode)	Addresses (Byte Mode)	Data	Description
40h	80h	0050h	
41h	82h	0052h	Query-unique ASCII string "PRI"
42h	84h	0049h	
43h	86h	0031h	Major version number, ASCII
44h	88h	0033h	Major version number, ASCII
45h	8Ah	000Ch	Address Sensitive Unlock 0=Required, 1=Not Required
46h	8Ch	0002h	Erase Suspend 0=Not Supported, 1=To Read Only, 2=To Read and Write
47h	8Eh	0001h	Sector Protect 0=Not Supported, X=Number of Sectors Per Group
48h	90h	0001h	Sector Temorary Unprotect 00=Not Supported, 01=Supported
49h	92h	0004h	Sector Protect / Unprotect Scheme 01=29F040 mode, 02=29F016 mode, 03=29F400 mode, 04=29LV800A mode
4Ah	94h	0000h	Simultaneous Operation 00=Not Supported, 01=Supported
4Bh	96h	0000h	Burst Mode Type 00=Not Supported, 01= Supported
4Ch	98h	0000h	Page Mode Type 00=Not Supported, 01=4 Word Page, 02= 8 Word Page
4Dh	9Ah	0000h	ACC (Acceleration) Supply Minimum 00=Not Supported, D7-D4: Volt, D3-D0; 100mV
4Eh	9Ch	0000h	ACC (Acceleration) Supply Minimum 00=Not Supported, D7-D4: Volt, D3-D0; 100mV

#### WWW.DHARDWARE DATA PROTECTION

The command sequence requirement of unlock cycles for programming or erasing provides data protection against inadvertent writes (refer to Table 9 on page 21 for command definitions). In addition, the following hardware data protection measures prevent accidental erasure or programming, which might otherwise be caused by spurious system level signals during  $V_{\rm cc}$  power-up and power-down transitions, or from system noise.

#### LOW V<sub>cc</sub> WRITE INHIBIT

When  $V_{cc}^{cc}$  is less than  $V_{LKO}$ , the device does not accept any write cycles. This protects data during  $V_{cc}$  power-up and power-down. The command register and all internal program/erase circuits are disabled, and the device resets. Subsequent writes are ignored until  $V_{cc}$  is greater than  $V_{LKO}$ . The system must provide the proper signals to the control pins to prevent unintentional writes when  $V_{cc}$  is greater than  $V_{LKO}$ .

#### WRITE PULSE GLITCH PROTECTION

Noise pulses of less than 5 ns (typical) on OE#, CE# or WE# do not initiate a write cycle.

#### LOGICAL INHIBIT

Write cycles are inhibited by holding any one of  $OE# = V_{IL}$ ,  $CE# = V_{IH}$  or  $WE# = V_{IH}$ . To initiate a write cycle, CE# and WE# must be a logical zero while OE# is a logical one.

#### POWER-UP WRITE INHIBIT

If WE# = CE# =  $V_{IL}$  and OE# =  $V_{IH}$  during power up, the device does not accept commands on the rising edge of WE#. The internal state machine is automatically reset to reading array data on power-up.

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## **COMMAND DEFINITIONS**

Writing specific address and data commands or sequences into the command register initiates device operations. Table 9 on page 21 defines the valid register command sequences. Writing **incorrect address and data values** or writing them in the **improper sequence** resets the device to reading array data.

All addresses are latched on the falling edge of WE# or CE#, whichever happens later. All data is latched on the rising edge of WE# or CE#, whichever happens first. Refer to the appropriate timing diagrams in AC Characteristics on page 29.

## **READING ARRAY DATA**

The device is automatically set to reading array data after device power-up. No commands are required to retrieve data. The device is also ready to read array data after completing an Embedded Program or Embedded Erase algorithm.

After the device accepts an Erase Suspend command, the device enters the Erase Suspend mode. The system can read array data using the standard read timings, except that if it reads at an address within erasesuspended sectors, the device outputs status data. After completing a programming operation in the Erase Suspend mode, the system may once again read array data with the same exception. See Erase Suspend/Erase Resume Commands on page 20 for more information on ataSheet4U.com

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The system must issue the reset command to re-enable the device for reading array data if DQ5 goes high, or while in the autoselect mode. See Reset Command, next.

See also Requirements for Reading Array Data on page 7 for more information. The Read Operations on page 29 provides the read parameters, and Figure 12, on page 29 shows the timing diagram.

### **RESET COMMAND**

Writing the reset command to the device resets the device to reading array data. Address bits are don't care for this command.

The reset command may be written between the sequence cycles in an erase command sequence before erasing begins. This resets the device to reading array data. Once erasure begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in a program command sequence before programming begins. This resets the device to reading array data (also applies to programming in Erase Suspend mode). Once programming begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in an autoselect command sequence. Once in the autoselect mode, the reset command must be written to return to reading array data (also applies to autoselect during Erase Suspend).

If DQ5 goes high during a program or erase operation, writing the reset command returns the device to reading array data (also applies during Erase Suspend).

## AUTOSELECT COMMAND SEQUENCE

The autoselect command sequence allows the host system to access the manufacturer and devices codes, and determine whether or not a sector is protected. Table 9 on page 21 shows the address and data requirements. This method is an alternative to that shown in Table 4 on page 11, which is intended for PROM programmers and requires  $V_{ID}$  on address bit A9.

The autoselect command sequence is initiated by writing two unlock cycles, followed by the autoselect command. The device then enters the autoselect mode, and the system may read at any address any number of times, without initiating another command sequence.

A read cycle at address XX00h retrieves the manufacturer code. A read cycle at address XX01h returns the device code. A read cycle containing a sector address (SA) and the address 02h in word mode (or 04h in byte mode) returns 01h if that sector is protected, or 00h if it is unprotected. Refer to Table 2 on page 9 and Table 3 on page 10 for valid sector addresses.

The system must write the reset command to exit the autoselect mode and return to reading array data.

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## WORD/BYTE PROGRAM COMMAND SEQUENCE

The system may program the device by word or byte, depending on the state of the BYTE# pin. Programming is a four-bus-cycle operation. The program command sequence is initiated by writing two unlock write cycles, followed by the program set-up command. The program address and data are written next, which in turn initiate the Embedded Program algorithm. The system is *not* required to provide further controls or timings. The device automatically generates the program pulses and verifies the programmed cell margin. Table 9 on page 21 shows the address and data requirements for the byte program command sequence.

When the Embedded Program algorithm is complete, the device then returns to reading array data and addresses are no longer latched. The system can determine the status of the program operation by using DQ7, DQ6, or RY/BY#. See Write Operation Status on page 22 for information on these status bits.

Any commands written to the device during the Embedded Program Algorithm are ignored. Note that a **hardware reset** immediately terminates the programming operation. The Byte Program command sequence should be reinitiated once the device has reset to reading array data, to ensure data integrity.

Programming is allowed in any sequence and across sector boundaries. A bit cannot be programmed from a  $\vec{0}$  back to a 1. Attempting to do so may halt the operation and set DQ5 to 1, or cause the Data# Polling algorithm to indicate the operation was successful. However, a succeeding read will show that the data is still 0. Only erase operations can convert a 0 to a 1.

## UNLOCK BYPASS COMMAND SEQUENCE

The unlock bypass feature allows the system to program bytes or words to the device faster than using the standard program command sequence. The unlock bypass command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle containing the unlock bypass command, 20h. The device then enters the unlock bypass mode. A two-cycle unlock bypass program command sequence is all that is required to program in this mode. The first cycle in this sequence contains the unlock bypass program command, A0h; the second cycle contains the program address and data. Additional data is programmed in the same manner. This mode dispenses with the initial two unlock cycles required in the standard program command sequence, resulting in faster total programming time. Table 9 on page 21 shows the requirements for the command sequence.

During the unlock bypass mode, only the Unlock Bypass Program and Unlock Bypass Reset commands are valid. To exit the unlock bypass mode, the system must issue the two-cycle unlock bypass reset command sequence. The first cycle must contain the data 90h; the second cycle the data 00h. Addresses are don't care for both cycles. The device then returns to reading array data.

Figure 3 illustrates the algorithm for the program operation. See Erase / Program Operations on page 32 for parameters, and to Figure 16, on page 33 for timing diagrams.



Note: See Table 9 on page 21 for program command sequence.

#### Figure 3. Program Operation

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## CHIP ERASE COMMAND SEQUENCE

Chip erase is a six bus cycle operation. The chip erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock write cycles are then followed by the chip erase command, which in turn invokes the Embedded Erase algorithm. The device does not require the system to preprogram prior to erase. The Embedded Erase algorithm automatically preprograms and verifies the entire memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations. Table 9 on page 21 shows the address and data requirements for the chip erase command sequence.

Any commands written to the chip during the Embedded Erase algorithm are ignored. Note that a **hardware reset** during the chip erase operation immediately terminates the operation. The Chip Erase command sequence should be reinitiated once the device has returned to reading array data, to ensure data integrity.

The system can determine the status of the erase operation by using DQ7, DQ6, DQ2, or RY/BY#. See Write Operation Status on page 22 for information on these status bits. When the Embedded Erase algorithm is complete, the device returns to reading array data and addresses are no longer latched.

Figure 4, on page 20 illustrates the algorithm for the erase www.Doperation.See Erase / Program Operations on page 32 for parameters, and Figure 17, on page 33 for timing diagrams.

## SECTOR ERASE COMMAND SEQUENCE

Sector erase is a six bus cycle operation. The sector erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock write cycles are then followed by the address of the sector to be erased, and the sector erase command. Table 9 on page 21 shows the address and data requirements for the sector erase command sequence.

The device does *not* require the system to preprogram the memory prior to erase. The Embedded Erase algorithm automatically programs and verifies the sector for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations. After the command sequence is written, a sector erase time-out of 50 µs begins. During the time-out period, additional sector addresses and sector erase commands may be written. Loading the sector erase buffer may be done in any sequence, and the number of sectors may be from one sector to all sectors. The time between these additional cycles must be less than 50 us, otherwise the last address and command might not be accepted, and erasure may begin. It is recommended that processor interrupts be disabled during this time to ensure all commands are accepted. The interrupts can be reenabled after the last Sector Erase command is written. If the time between additional sector erase commands can be assumed to be less than 50 µs, the system need not monitor DQ3. Any command other than Sector Erase or Erase Suspend during the time-out period resets the device to reading array data. The system must rewrite the command sequence and any additional sector addresses and commands.

The system can monitor DQ3 to determine if the sector erase timer has timed out. (See DQ3: Sector Erase Timer on page 25.) The time-out begins from the rising edge of the final WE# pulse in the command sequence.

Once the sector erase operation has begun, only the Erase Suspend command is valid. All other commands are ignored. Note that a **hardware reset** during the sector erase operation immediately terminates the operation. The Sector Erase command sequence should be reinitiated once the device has returned to reading array data, to ensure data integrity.

When the Embedded Erase algorithm is complete, the device returns to reading array data and addresses are no longer latched. The system can determine the status of the erase operation by using DQ7, DQ6, DQ2, or RY/BY#. (Refer to Write Operation Status on page 22 for information on these status bits.)

Figure 4 illustrates the algorithm for the erase operation. Refer to Erase / Program Operations on page32 for parameters, and to Figure 17, on page 33 for timing diagrams.



## ERASE SUSPEND / ERASE RESUME COMMANDS

The Erase Suspend command allows the system to interrupt a sector erase operation and then read data from, or program data to, any sector not selected for erasure. This command is valid only during the sector erase operation, including the 50 µs time-out period during the sector erase command sequence. The Erase Suspend command is ignored if written during the chip erase operation or Embedded Program algorithm. Writing the Erase Suspend command during the Sector Erase time-out immediately terminates the time-out period and suspends the erase operation. Addresses are don't-cares when writing the Erase Suspend command.

When the Erase Suspend command is written during a sector erase operation, the device requires a maximum of 20 µs to suspend the erase operation. However, when the Erase Suspend command is written during the sector erase time-out, the device immediately terminates the time-out period and suspends the erase operation.

After the erase operation has been suspended, the system can read array data from or program data to any sector not selected for erasure. (The device "erase suspends" all sectors selected for erasure.) Normal read and write timings and command definitions apply. Reading at any address within erase-suspended sectors produces status data on DQ7–DQ0. The system can use DQ7, or DQ6 and DQ2 together, to determine if a sector is actively erasing or is erase-suspended. See Write Operation Status on page 22 for information on these status bits.

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After an erase-suspended program operation is complete, the system can once again read array data within nonsuspended sectors. The system can determine the status of the program operation using the DQ7 or DQ6 status bits, just as in the standard program operation. See Write Operation Status on page 22 for more information.

The system may also write the autoselect command sequence when the device is in the Erase Suspend mode. The device allows reading autoselect codes even at addresses within erasing sectors, since the codes are not stored in the memory array. When the device exits the autoselect mode, the device reverts to the Erase Suspend mode, and is ready for another valid operation. See Autoselect Command Sequence on page 17 for more information. The system must write the Erase Resume command (address bits are don't care) to exit the erase suspend mode and continue the sector erase operation. Further writes of the Resume command are ignored. Another Erase Suspend command can be written after the device has resumed erasing.



#### Notes:

- 1. See Table 9 on page 21 for erase command sequence.
- 2. See DQ3: Sector Erase Timer on page 25 for more information.

#### Figure 4. Erase Operation

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### **TABLE 9: COMMAND DEFINITIONS**

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			Cycles						Bus Cy	cles <sup>2-5</sup>					
				Fi	rst	Sec	ond	Th	ird		urth	Fi	fth	Siz	<b>cth</b>
	Command Sequence	1	Ú.	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data
Rea	Read <sup>6</sup>		1	RA	RD										
Res	et <sup>7</sup>		1	XXX	F0										
	Manufacturer ID	Word	4	555	AA	2AA	55	555	90	X00	01				
		Byte		AAA	,	555	00	AAA	00		-				
~	Device ID,	Word	4	555	AA	2AA	55	55 555	90	X01	22C4				
Autoselect <sup>8</sup>	Top Boot Block	Byte	· ·	AAA	,	555		AAA		X02	C4				
sele	Device ID,	Word	4	555	AA	2AA	55	555	90	X01	2249				
îţ	Bottom Boot Block	Byte		AAA		555		AAA		X02	49				
٩٢		Word		555		2AA		555		(SA)	XX00				
	Sector Protect Verify <sup>9</sup>		4		AA		55		90	X02	XX01				
	, , ,	Byte		AAA		555		AAA		(SA)	00				
		Word		55						X04	01				
CEI	Query <sup>10</sup>	Byte	1	AA	98										
CFI	Query	Word		555		2AA		555							
Pro	gram	Byte	4	AAA	AA	555	55	AAA	A0	PA	PD				
110	gram	Word		555		2AA		555							
Unk	ock Bypass	Byte	3	AAA	AA	555	55	AAA	20						
	ock Bypass Program <sup>11</sup>	Dyto	2	XXX	A0	PA	PD	7000							
Unk	ock Bypass Reset <sup>12</sup>		2	XXX	90	XXX	F0								
OTIN		Word		555		2AA	-	555		555		2AA		555	
Chi	Chip Erase		6	AAA	AA	555	55	AAA	80	AAA	AA	555	55	AAA	10
				555		2AA		555		555		2AA			
Sector Erase B		Byte	6	AAA	AA	555	55	AAA	80	AAA	AA	555	55	SA	30
Erase Suspend <sup>13</sup>		1	XXX	B0											
Eras	se Resume <sup>14</sup>		1	XXX	30										

#### Legend:

X = Don't care

RA = Address of the memory location to be read.

RD = Data read from location RA during read operation.

PA = Address of the memory location to be programmed. Addresses latch on the falling edge of the WE# or CE# pulse, whichever www.DataShbappens\_later.

PD = Data to be programmed at location PA. Data latches on the rising edge of WE# or CE# pulse, whichever happens first.

SA = Address of the sector to be verified (in autoselect mode) or erased. Address bits A19–A12 uniquely select any sector.

#### Note:

- 1. See Table 1 for description of bus operations.
- 2. All values are in hexadecimal.
- 3. Except for the read cycle and the fourth cycle of the autoselect command sequence, all bus cycles are write cycles.
- 4. Data bits DQ15-DQ8 are don't cares for unlock and command cycles.
- 5. Address bits A19-A11 are don't cares for unlock and command cycles, unless SA or PA required.
- 6. No unlock or command cycles required when reading array data.
- 7. The Reset command is required to return to reading array data when device is in the autoselect mode, or if DQ5 goes high (while the device is providing status data).
- 8. The fourth cycle of the autoselect command sequence is a read cycle.
- 9. The data is 00h for an unprotected sector and 01h for a protected sector. See "Autoselect Command Sequence" for more information.
- 10. Command is valid when device is ready to read array data or when device is in autoselect mode.
- 11. The Unlock Bypass command is required prior to the Unlock Bypass Program command.
- 12. The Unlock Bypass Reset command is required to return to reading array data when the device is in the unlock bypass mode. F0 is also acceptable.
- 13. The system may read and program in non-erasing sectors, or enter the autoselect mode, when in the Erase Suspend mode. The Erase Suspend command is valid only during a sector erase operation.
- 14. The Erase Resume command is valid only during the Erase Suspend mode.



## WRITE OPERATION STATUS

The device provides several bits to determine the status of a write operation: DQ2, DQ3, DQ5, DQ6, DQ7, and RY/BY#. Table 10 on page 25 and the following subsections describe the functions of these bits. DQ7, RY/BY#, and DQ6 each offer a method for determining whether a program or erase operation is complete or in progress. These three bits are discussed first.

#### **DQ7: DATA# POLLING**

The Data# Polling bit, DQ7, indicates to the host system whether an Embedded Algorithm is in progress or completed, or whether the device is in Erase Suspend. Data# Polling is valid after the rising edge of the final WE# pulse in the program or erase command sequence.

During the Embedded Program algorithm, the device outputs on DQ7 the complement of the datum programmed to DQ7. This DQ7 status also applies to programming during Erase Suspend. When the Embedded Program algorithm is complete, the device outputs the datum programmed to DQ7. The system must provide the program address to read valid status information on DQ7. If a program address falls within a protected sector, Data# Polling on DQ7 is active for approximately 1 µs, then the device returns to reading array data.

During the Embedded Erase algorithm, Data# Polling produces a 0 on DQ7. When the Embedded Erase algorithm is complete, or if the device enters the Erase www.DSuspend.mode, Data# Polling produces a 1 on DQ7. This is analogous to the complement/true datum output described for the Embedded Program algorithm: the erase function changes all the bits in a sector to 1; prior to this, the device outputs the *complement*, or 0. The system must provide an address within any of the sectors selected for erasure to read valid status information on DQ7.

After an erase command sequence is written, if all sectors selected for erasing are protected, Data# Polling on DQ7 is active for approximately  $100 \,\mu$ s, then the device returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected.

When the system detects DQ7 has changed from the complement to true data, it can read valid data at DQ7–DQ0 on the *following* read cycles. This is because DQ7 may change asynchronously with DQ0–DQ6 while Output Enable (OE#) is asserted low. Figure 18, on page 34, illustrates this.

Table 10 on page 25 shows the outputs for Data# Polling on DQ7. Figure 5 below shows the Data# Polling algorithm.



- VA = Valid address for programming. During a sector erase operation, a valid address is an address within any sector selected for erasure. During chip erase, a valid address is any non-protected sector address.
- 2. DQ7 should be rechecked even if DQ5 = 1 because DQ7 may change simultaneously with DQ5.

Figure 5. Data# Polling Algorithm

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#### RY/BY#: READY/BUSY#

The RY/BY# is a dedicated, open-drain output pin that indicates whether an Embedded Algorithm is in progress or complete. The RY/BY# status is valid after the rising edge of the final WE# pulse in the command sequence. Since RY/BY# is an open-drain output, several RY/BY# pins can be tied together in parallel with a pull-up resistor to VCC.

If the output is low (Busy), the device is actively erasing or programming. (This includes programming in the Erase Suspend mode.) If the output is high (Ready), the device is ready to read array data (including during the Erase Suspend mode), or is in the standby mode.

Table 10 on page 25 shows the outputs for RY/BY#. Figures: Figure 12, on page 29, Figure 13, on page 30, Figure 16, on page 33 and Figure 17, on page 33 shows RY/BY# for read, reset, program, and erase operations, respectively.

### DQ6: TOGGLE BIT I

Toggle Bit I on DQ6 indicates whether an Embedded Program or Erase algorithm is in progress or complete, or whether the device has entered the Erase Suspend mode. Toggle Bit I may be read at any address, and is valid after the rising edge of the final WE# pulse in the command sequence (prior to the program or erase operation), and during the sector erase time-out.

During an Embedded Program or Erase algorithm operation, successive read cycles to any address cause DQ6 to toggle. (The system may use either OE# or CE# to control the read cycles.) When the operation is complete, DQ6 stops toggling.

After an erase command sequence is written, if all sectors selected for erasing are protected, DQ6 toggles for approximately 100  $\mu$ s, then returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected.

The system can use DQ6 and DQ2 together to determine whether a sector is actively erasing or is erase-suspended. When the device is actively erasing (that is, the Embedded Erase algorithm is in progress), DQ6 toggles. When the device enters the Erase Suspend mode, DQ6 stops toggling. However, the system must also use DQ2 to determine which sectors are erasing or erase-suspended. Alternatively, the system can use DQ7 (see the subsection on DQ7: Data# Polling on page 22). If a program address falls within a protected sector, DQ6 toggles for approximately 1  $\mu$ s after the program command sequence is written, then returns to reading array data.

DQ6 also toggles during the erase-suspend-program mode, and stops toggling once the Embedded Program algorithm is complete.

Table 10 on page 25 shows the outputs for Toggle Bit I on DQ6. Figure 6, on page 24 shows the toggle bit algorithm in flowchart form, and Reading Toggle Bits DQ6/ DQ2 on page 24 explains the algorithm. Figure 19, on page 34 shows the toggle bit timing diagrams. Figure 20, on page 5 shows the differences between DQ2 and DQ6 in graphical form. See also the subsection on DQ2: Toggle Bit II below.

## DQ2: TOGGLE BIT II

The "Toggle Bit II" on DQ2, when used with DQ6, indicates whether a particular sector is actively erasing (that is, the Embedded Erase algorithm is in progress), or whether that sector is erase-suspended. Toggle Bit II is valid after the rising edge of the final WE# pulse in the command sequence.

DQ2 toggles when the system reads at addresses within those sectors that have been selected for erasure. (The system may use either OE# or CE# to control the read cycles.) But DQ2 cannot distinguish whether the sector is actively erasing or is erase-suspended. DQ6, by comparison, indicates whether the device is actively erasing, or is in Erase Suspend, but cannot distinguish which sectors are selected for erasure. Thus, both status bits are required for sector and mode information. Refer to Table 10 on page 25 to compare outputs for DQ2 and DQ6.

Figure 6, on page 24 shows the toggle bit algorithm in flowchart form, and the section Reading Toggle Bits DQ6/ DQ2 on page 24 explains the algorithm. See also the DQ6: Toggle Bit I subsection. Figure 19, on page 34 shows the toggle bit timing diagram. Figure 20, on page 35 shows the differences between DQ2 and DQ6 in graphical form.

#### **READING TOGGLE BITS DQ6/DQ2**

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Refer to Figure 6 for the following discussion. Whenever the system initially begins reading toggle bit status, it must read DQ7–DQ0 at least twice in a row to determine whether a toggle bit is toggling. Typically, the system would note and store the value of the toggle bit after the first read. After the second read, the system would compare the new value of the toggle bit with the first. If the toggle bit is not toggling, the device has completed the program or erase operation. The system can read array data on DQ7–DQ0 on the following read cycle.

However, if after the initial two read cycles, the system determines that the toggle bit is still toggling, the system also should note whether the value of DQ5 is high (see the section on DQ5). If it is, the system should then determine again whether the toggle bit is toggling, since the toggle bit may have stopped toggling just as DQ5 went high. If the toggle bit is no longer toggling, the device has successfully completed the program or erase operation. If it is still toggling, the device did not complete the operation successfully, and the system must write the reset command to return to reading array data.

The remaining scenario is that the system initially determines that the toggle bit is toggling and DQ5 has not gone high. The system may continue to monitor the toggle bit and DQ5 through successive read cycles, determining the status as described in the previous paragraph. Alternatively, it may choose to perform other www.D system tasks. In this case, the system must start at the beginning of the algorithm when it returns to determine the status of the operation (top of Figure 6).

START Read DQ7-DQ0 (Note 1) Read DQ7-DQ0 Toggle Bit No = Toggle? Yes No DQ5 = 1?Yes (Notes Read DQ7-DQ0 1,2) Twice Toggle Bit No = Toggle? Yes Program/Erase Program/Erase **Operation Not** Complete, Write Operation Complete **Reset Command** 

#### Notes:

- 1. Read toggle bit twice to determine whether or not it is toggling. See text.
- 2. Recheck toggle bit because it may stop toggling as DQ5 changes to 1. See text.

Figure 6. Toggle Bit Algorithm

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#### **DQ5: EXCEEDED TIMING LIMITS**

DQ5 indicates whether the program or erase time has exceeded a specified internal pulse count limit. Under these conditions DQ5 produces a 1. This is a failure condition that indicates the program or erase cycle was not successfully completed.

The DQ5 failure condition may appear if the system tries to program a 1 to a location that is previously programmed to 0. **Only an erase operation can change a 0 back to a 1**. Under this condition, the device halts the operation, and when the operation has exceeded the timing limits, DQ5 produces a 1.

Under both these conditions, the system must issue the reset command to return the device to reading array data.

#### **DQ3: SECTOR ERASE TIMER**

After writing a sector erase command sequence, the system may read DQ3 to determine whether or not an erase operation has begun. (The sector erase timer does not apply to the chip erase command.) If additional sectors are selected for erasure, the entire time-out also applies after each additional sector erase command. When the time-out is complete, DQ3 switches from 0 to 1. The system may ignore DQ3 if the system can guarantee that the time between additional sector erase commands will always be less than 50 µs. See also the Sector Erase Command Sequence section on page 19.

After the sector erase command sequence is written, the system should read the status on DQ7 (Data# Polling) or DQ6 (Toggle Bit I) to ensure the device has accepted the command sequence, and then read DQ3. If DQ3 is 1, the internally controlled erase cycle has begun; all further commands (other than Erase Suspend) are ignored until the erase operation is complete. If DQ3 is 0, the device will accept additional sector erase commands. To ensure the command has been accepted, the system software should check the status of DQ3 prior to and following each subsequent sector erase command. If DQ3 is high on the second status check, the last command might not have been accepted. Table 10 shows the outputs for DQ3.

	Operation	DQ7 <sup>2</sup>	DQ6	DQ1 <sup>1</sup>	DQ3	DQ2 <sup>2</sup>	RY/BY#
Standard	Embedded Program Algorithm	DQ7#	Toggle	0	N/A	No Toggle	0
Mode	Embedded Erase Algorithm	0	Toggle	0	1	Toggle	0
Suspend	Reading within Erase Suspended Sector	1	No Toggle	0	N/A	Toggle	1
	Reading within Non-Erase Suspended Sector	Data	Data	Data	Data	Data	1
	Erase-Suspend-Program	DQ7#	Toggle	0	N/A	N/A	0

#### www.Datable 10; Write Operation Status

#### Notes:

1. DQ5 switches to 1 when and Embedded Program or Embedded Erase operation has exceeded the maximum timing limits. See DQ5: Exceeded Timing Limits for more information.

2. DQ7 and DQ2 require a valid address when reading status information. Refer to the appropriate subsection for further details.

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	BOOT	SECTOR FLASH
SEMICONDUCTOR Austin Semiconductor,	Inc.	AS29LV016J

#### **ABSOLUTE MAXIMUM RATINGS**

Storage Temperature Plastic Packages	–65°C to +150°C
Ambient Temperature with Power Applied	–65°C to +125°C
Voltage with Respect to Ground	
$V_{cc}^{1}$	–0.5 V to +4.0 V
A9, OE#, and RESET# <sup>2</sup>	
All other pins <sup>1</sup>	$\dots \dots $
Output Short Circuit Current <sup>3</sup>	

#### Notes:

- 1. Minimum DC voltage on input or I/O pins is -0.5 V. During voltage transitions, input or I/O pins may overshoot  $V_{ss}$  to -2.0 V for periods of up to 20 ns. See Figure 7 below. Maximum DC voltage on input or I/O pins is  $V_{cc}$  +0.5 V. During voltage transitions, input or I/O pins may overshoot to  $V_{cc}$  +2.0 V for periods up to 20 ns. See Figure 8 below.
- 2.Minimum DC input voltage on pins A9, OE#, and RESET# is -0.5 V. During voltage transitions, A9, OE#, and RESET# may overshoot V<sub>ss</sub> to –2.0 V for periods of up to 20 ns. See Figure 7 below. Maximum DC input voltage on pin A9 is +12.5 V which may overshoot to 14.0 V for periods up to 20 ns.
- 3.No more than one output may be shorted to ground at a time. Duration of the short circuit should not be greater than one second.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this data sheet is not implied. Exposure of the device to absolute maximum rating conditions for extended periods may affect device reliability.

#### **OPERATING RANGES**

#### Enhanced (/ET) Devices

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#### Extended (/XT) Devices

#### V<sub>cc</sub> Supply Voltages

Operating ranges define those limits between which the functionality of the device is guaranteed.





Figure 8. Maximum Positive Overshoot Waveform



## **DC CHARACTERISTICS**

#### CMOS Compatible

Parameter	Description	Test Conditions		Min	Тур	Max	Unit
1	Input Load Current	$V_{IN}=V_{SS}$ to $V_{CC}$ , $V_{CC}=V_{CCmax}$				±1.0	
ILI	WP# Input Load Current	$V_{CC}=V_{CCmax}$ , Wp#= $V_{SS}$ to $V_{CC}$				±25	
I <sub>LIT</sub>	A9 Input Load Current	V <sub>CC</sub> =V <sub>CCmax</sub> ; A9=12.5V				35	μA
I <sub>LO</sub>	Output Leakage Current	$V_{OUT}=V_{SS}$ to $V_{CC}$ , $V_{CC}=V_{CCmax}$				±1.0	
		CE#=V <sub>IL</sub> , OE#-V <sub>IH</sub> , Byte Mode	5 MHz		7	12	
I <sub>CC1</sub>	V <sub>CC</sub> Active Read Current <sup>1,2</sup>		1 MHz		2	4	mA
·CC1		CE#=V <sub>IL</sub> , OE#-V <sub>IH</sub> , Word Mode	5 MHz		7	12	
			1 MHz		2	4	
I <sub>CC2</sub>	V <sub>CC</sub> Erase/Program Current <sup>2,3,4</sup>	CE#=V <sub>IL</sub> , OE#=V <sub>IH</sub> , V <sub>CC=</sub> V <sub>CCmax</sub>			20	30	mA
I <sub>CC3</sub>	V <sub>CC</sub> Standby Current <sup>2,4</sup>	OE3=V <sub>IH</sub> . RESET#=V <sub>CC</sub> ±0.3V/-0.1V, WP#=Vcc or open, Vccmax <sup>5</sup>	CE#,		0.2	10	μA
I <sub>CC4</sub>	V <sub>CC</sub> Standby Current During Reset <sup>2,4</sup>	Vcc=Vccmax, RESET#=VSS ±0. WP#=Vcc or open <sup>5</sup>		0.2	10	μA	
I <sub>CC5</sub>	Automatic Sleep Mode <sup>2,4,6</sup>	$V_{IH}=V_{CC} \pm 0.3V$ ; $V_{IL}=V_{SS} \pm 0.3V$			0.2		μA
V <sub>IL</sub>	Input Low Voltage			-0.1		0.8	
V <sub>IH</sub>	Input High Voltage	1		$0.7 \times V_{CC}$		V <sub>CC</sub> + 0.3	
V <sub>ID</sub>	Voltage for Autoselect and Temporary Sector Unprotect	V <sub>CC</sub> =2.7-3.6V		8.5		12.5	
V <sub>OL</sub>	Output Low Voltage	I <sub>OL</sub> =4.0 mA, V <sub>CC</sub> =V <sub>CCmin</sub>				0.45	V
V <sub>OH1</sub>		I <sub>OH</sub> =-2.0 mA, V <sub>CC</sub> =V <sub>CCmin</sub>		.85xVcc			
V <sub>OH2</sub>	Output High Voltage	$I_{OH}$ =-100 µA, V <sub>CC</sub> =V <sub>CCmin</sub>		V <sub>CC</sub> -0.4			
V <sub>LKO</sub>	Low V <sub>CC</sub> Lock-Out Voltage			2.3		2.5	

#### Notes:

www.DataThedetecurrent listed is typically less than 2 mA/MHz, with OE# at  $V_{\mu}$ . Typical  $V_{cc}$  is 3.0 V.

2.<sub>cc</sub> active while Embedded Erase or Embedded Program is in progress.

3. Automatic sleep mode enables the low power mode when addresses remain stable for  $t_{ACC}$  + 30 ns.

4.Not 100% tested.

5. When the device is operated in Extended Temperature range, the currents are as follows:

*I<sub>cc3</sub>-0.2*μA (typ), 10μA (max)

*I<sub>CC4</sub>-0.2*μA (typ), 10μA (max)

I<sub>ccs</sub>-0.2μA (typ), 10μA (max)

#### AUSTIN SEMICONDUCTOR Austin Semiconductor, Inc. COTS PEM BOOT SECTOR FLASH AS29LV016J

## **TEST CONDITIONS**



Note: Diodes are IN3064 or equivalent

#### Figure I0. Test Setup

#### Table 11: Test Specifications

Test Condition	70	55	Unit	
Output Load		1 TTL gate		
Output Load Capacitance, CL (including jig capacitance)	3	30		
Input Rise and Fall Times		ns		
Input Pulse Levels	0.0 c	or V <sub>CC</sub>		
Input timing measurement reference levels	0.5	V <sub>CC</sub>	V	
Output timing meausrement reference levels	0.5	V <sub>CC</sub>		

### Key to Switching Waveforms

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WAVEFORM	INPUTS	OUTPUTS						
	Steady							
	Cha	Changing from H to L						
	Changing from L to H							
XXXXXX	Don't Care, Any Change Permitted	Changing, State Unknown						
	Does Not Apply	Center Line is High Impedance State (High Z)						
$V_{CC}$ Input $0.5 V_{CC}$ Measurement Level $\rightarrow$ $0.5 V_{CC}$ Output								





## **AC CHARACTERISTICS**

#### **Read Operations**

Parameter						Speed		
JEDEC	Std		Description	Test	Setup	70	55	Unit
t <sub>AVAV</sub>	t <sub>RC</sub>	Read Cycle Time	1		Min	70	55	
t <sub>AVQV</sub>	t <sub>ACC</sub>	Address to Outpu	ut Delay	CE#=V <sub>IL</sub> , OE#=V <sub>IL</sub>	Max	70	55	
$t_{ELQV}$	$\mathbf{t}_{CE}$	Chip Enable to C	OE#=V <sub>IL</sub>	Max	70	55		
t <sub>GLQV</sub>	$t_{OE}$	Output Enable to	Output Enable to Output Delay			30	30	
t <sub>EHQZ</sub>	$t_{DF}$	Chip Enable to C	Chip Enable to Ouput High Z <sup>1</sup>			16		
t <sub>GHQZ</sub>	$t_{DF}$	Output Enable to	Output High Z <sup>1</sup>		Max		16	ns
	t <sub>SR/W</sub>	Latency Betweer	Read and Write Operations		Min	20		
	t	Output Enable	Read		Min	0		]
	t <sub>OEH</sub>	Hold Time <sup>1</sup>	Toggle and Data# Polling		Min		10	
t <sub>AXQX</sub>	t <sub>OH</sub>		Output Hold Time From Addresses, CE# or OE#, Whichever Occurs First <sup>1</sup>				0	

#### Notes:

1. Not 100% Tested

2. See Figure 10, on page 28 and Table 11 on page 28 for test specifications.







## **AC CHARACTERISTICS**

### Hardware Reset (RESET#)

Parar	neter				
JEDEC	Std	Description	Test Setup	All Speed Options	Unit
		RESET# Pin Low (During Embedded Algorithms) to Read or Write <sup>1</sup>	Max	35	μs
		RESET# Pin Low (NOT During Embedded Algorithms) to Read or Write <sup>1</sup>	Max	500	
	t <sub>RP</sub>	RESET# Pulse Width		500	ns
	t <sub>RH</sub>	RESET# High Time Before Read <sup>1</sup>	Min	50	
	t <sub>RPD</sub>	RESET# Low to Standby Mode		35	μs
	t <sub>RB</sub>	RY/BY# Recovery Time		0	ns

#### Note:

1. Not 100% Tested







## AC CHARACTERISTICS

### Word / Byte Configuration (BYTE#)

Parameter				Speed Options		
JEDEC	Std	Description	<b>Test Setup</b>	70	55	Unit
	t <sub>ELFL</sub> / t <sub>ELFH</sub>	CE# to BYTE# Switching Low or High	Max	5		
	t <sub>FLQZ</sub>	BYTE# Switching Low to Output HIGH Z	Max	16		ns
	t <sub>FHQV</sub>	BYTE# Switching High to Output Active	Min	70 55		







## **AC CHARACTERISTICS**



**Note:** Refer to the Erase/Program Operations table for  $t_{AS}$  and  $t_{AH}$  specifications.

#### Figure I5. BYTE# Timings for Write Operations

#### Erase / Program Operations

	Parar	meter				Speed (	Options	
	JEDEC	Std	Description		Test Setup	70	55	Unit
	t <sub>AVAV</sub>	t <sub>WC</sub>	Write Cycle Time <sup>1</sup>			70	55	
	t <sub>AVWL</sub>	t <sub>AS</sub>	Address Setup Time			(		
	t <sub>WLAX</sub>	t <sub>AH</sub>	Address Hold Time	] [	45			
	t <sub>DVWH</sub>	t <sub>DS</sub>	Data Setup Time	35 35		35		
	t <sub>WHDX</sub>	t <sub>DH</sub>	Data Hold Time			(	)	
		t <sub>OES</sub>	Output Enagle Setup Time		(	)		
	t <sub>GHWL</sub>	t <sub>GHWL</sub>	Read Recovery Time Before Write, (OE# High to WE# Low)	Min	0		ns	
	t <sub>ELWL</sub>	t <sub>cs</sub>	CE# Setup Time	1	(			
www.Da	taSheet4U.co	<sup>m</sup> t <sub>сн</sub>	CE# Hold Time		0 35			
	t <sub>wLWH</sub>	t <sub>WP</sub>	Write Pulse Width	1				
	t <sub>WHWL</sub>	t <sub>wPH</sub>	Write Pulse Width High		1	25		1
		t <sub>SR/W</sub>	Latency Between Read and Write Operations		1	2	0	
	+	+	$\mathbf{D}_{\mathbf{r}}$	Byte		6		
	t <sub>WHWH1</sub>	t <sub>WHWH1</sub>	Programming Operation <sup>2</sup>	Word	Тур	6	3	μs
	t <sub>WHWH2</sub>	t <sub>WHWH2</sub>	Sector Erase Operation <sup>2</sup>			0.	5	sec
		t <sub>VCS</sub>	V <sub>cc</sub> Setup Time <sup>1</sup>		Min	5	0	μs
		t <sub>RB</sub>	Recovery Time from RY / BY#		IVIII	(	)	<b></b>
		t <sub>BUSY</sub>	Program / Erase Valid to RY / BY# Delay		Max	9	0	ns

Notes:

1. Not 100% Tested.

2. See Erase and Programming Performance on page 38 for more information.



## **AC CHARACTERISTICS**



#### Notes:

1. PA = program address, PD = program data,  $D_{OUT}$  is the true data at the program address.

2. Illustration shows device in word mode.

Figure I6. Program Operation Timings



#### Notes:

1.SA = sector address (for Sector Erase), VA = Valid Address for reading status data (see Write Operation Status on page 22).

2.Illustration shows device in word mode.

Figure I7. Chip/Sector Erase Operation Timings



## **AC CHARACTERISTICS**



**Note:** VA = Valid address. Illustration shows first status cycle after command sequence, last status read cycle, and array data read cycle.

Figure 18. Data# Polling Timings (During Embedded Algorithms)



**Note:** VA = Valid address; not required for DQ6. Illustration shows first two status cycle after command sequence, last status read cycle, and array data read cycle.





## **AC CHARACTERISTICS**



**Note:** The system may use CE# or OE# to toggle DQ2 and DQ6. DQ2 toggles only when read at an address within an erase-suspended sector.



#### **Temporary Sector Unprotect**

Parameter					
JEDEC	Std	Description	<b>Test Setup</b>	All Speed Options	Unit
	t <sub>VIDR</sub>	V <sub>ID</sub> Rise and Fall Time <sup>1</sup>	Min	500	ns
	t <sub>RSP</sub>	RESET# Setup Time for Temporary Sector Unprotect	Min	4	μs
	1 DOD	RESET# Hold Time from RY/BY# High for Temporary Sector Unprotected	Min	4	μs

Note:

1. Not 100% Tested.









**Note:** For sector protect, A6 = 0, A1 = 1, A0 = 0. For sector unprotect, A6 = 1, A1 = 1, A0 = 0.

Figure 22. Sector Protect/Unprotect Timing Diagram

#### Alternate CE# Controlled Erase / Program Operations

	Parameter					Speed (	Options	
www.Da	taS <b>JEDEC</b> J.co	m Std	Description		Test Setup	70	55	Unit
	t <sub>AVAV</sub>	t <sub>WC</sub>	Write Cycle Time <sup>1</sup>		70	55		
	t <sub>AVEL</sub>	t <sub>AS</sub>	Address Setup Time	[	(	)		
	t <sub>ELAX</sub>	t <sub>AH</sub>	Address Hold Time		[	45	45	
	t <sub>DVEH</sub>	t <sub>DS</sub>	Data Setup Time		1	35	35	
	t <sub>EHDX</sub>	t <sub>DH</sub>	Data Hold Time		1	0		
		t <sub>OES</sub>	Output Enagle Setup Time		1	(	)	
	t <sub>GHEL</sub>	t <sub>GHEL</sub>	Read Recovery Time Before Write, (OE# High to OE# Low)		Min	0		ns
	t <sub>WLEL</sub>	t <sub>ws</sub>	WE# Setup Time		[	(	)	
	t <sub>EHWH</sub>	t <sub>WH</sub>	WE# Hold Time		1	(	)	
	t <sub>ELEH</sub>	t <sub>CP</sub>	CE# Pulse Width			35	35	
	t <sub>EHEL</sub>	t <sub>CPH</sub>	CE# Pulse Width High		1	25		
		t <sub>SR/W</sub>	Latency Between Read and Write Operations		[	2	0	
	t <sub>whwh1</sub> t <sub>whwh1</sub>		Programming Operation <sup>2</sup>	Byte		6		μs
			Word		Тур	6		μ3
	t <sub>WHWH2</sub>	t <sub>WHWH2</sub>	Sector Erase Operation <sup>2</sup>			0.	5	sec

#### Notes:

1. Not 100% Tested.

2. See Erase and Programming Performance on page 38 for more information.



## **AC CHARACTERISTICS**



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#### Notes:

- 1. PA = program address, PD = program data, DQ7# = complement of the data written to the device, D<sub>OUT</sub> = data written to the device.
- 2. Figure indicates the last two bus cycles of the command sequence.
- 3. Word mode address used as an example.

#### Figure 23. Alternate CE# Controlled Write Operation Timings

## COTS PEM BOOT SECTOR FLASH Inc. AS29LV016J

Austin Semiconductor, Inc.

## ERASE AND PROGRAMMING PERFORMANCE

Parameter	Typ <sup>1</sup>	Max <sup>2</sup>	Unit	Comments
Sector Erase Time	0.5	10	s	Excludes 00h programming
Chip Erase Time	16		S	prior to erasure <sup>4</sup>
Byte Programming Time	6		μs	Excludes system level
Word Programming Time	6	150	μs	overhead <sup>5</sup>

#### Notes:

1. Typical program and erase times assume the following conditions:  $25^{\circ}C$ ,  $V_{cc} = 3.0$  V, 100,000 cycles, checkerboard data pattern.

2.Under worst case conditions of 90°C,  $V_{cc}$  = 2.7 V, 1,000,000 cycles.

3. The typical chip programming time is considerably less than the maximum chip programming time listed, since most bytes program faster than the maximum program times listed.

4.In the pre-programming step of the Embedded Erase algorithm, all bytes are programmed to 00h before erasure.

5.System-level overhead is the time required to execute the two- or four-bus-cycle sequence for the program command. See Table 9 on page 21 for further information on command definitions.

6. The device has a minimum erase and program cycle endurance of 100,000 cycles per sector.

## **TSOP PIN CAPACITANCE**

VSTIN

	Parameter Symbol	Parameter Description	Test Setup	Package	Тур	Мах	Unit
	C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> =0	TSOP	6	7.5	pF
	C <sub>OUT</sub>	Output Capacitance	V <sub>OUT</sub> =0	TSOP	8.5	12	pF
.Da	itaSh <b>€t</b> 4U.com	Control Pin Capacitance	V <sub>IN</sub> =0	TSOP	7.5	9	pF

#### Notes:

www.

1. Samples, not 100% tested.

2. Test conditions  $T_A = 25^{\circ} C$ , f=1.0 MHz



## COTS PEM BOOT SECTOR FLASH r, Inc. AS29LV016J

## PHYSICAL DIMENSIONS

#### TS 048—48-Pin Standard TSOP



				NOT	ES:
Jedec	MO-142 (D) DD		1	CONTROLLING DIMENSIONS ARE IN MILLIMETERS (mm). (DIMENSIONING AND TOLERANCING CONFORMS TO ANSI Y14.5M-1982)	
Symbol	MIN	NOM	MAX	2	
A	-	-	1.20	_	PIN 1 IDENTIFIER FOR REVERSE PIN OUT (DIE UP).
A1	0.05	-	0.15	3	PIN 1 IDENTIFIER FOR REVERSE PIN OUT (DIE DOWN), INK OR LASER MARK.
A2	0.95	1.00	1.05	4	TO BE DETERMINED AT THE SEATING PLANE C. THE SEATING PLANE IS DEFINED AS THE PLANE OF
b1	0.17	0.20	0.23		CONTACT THAT IS MADE WHEN THE PACKAGE LEADS ARE ALLOWED TO REST FREELY ON A FLAT
b	0.17	0.22	0.27	~	HORIZONTAL SURFACE.
c1	0.10	-	0.16	_5∖	DIMENSIONS D1 AND E DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE MOLD PROTUSION IS
С	0.10	-	0.21	~	0.15mm (.0059") PER SIDE.
D	19.80	20.00	20.20	6	DIMENSION b DOES NOT INCLUDE DAMBAR PROTUSION. ALLOWABLE DAMBAR PROTUSION SHALL BE
D1	18.30	18.40	18.50		0.08 (0.0031*) TOTAL IN EXCESS OF b DIMENSION AT MAX. MATERIAL CONDITION. MINIMUM SPACE
E	11.90	12.00	12.10	~	BETWEEN PROTRUSION AND AN ADJACENT LEAD TO BE 0.07 (0.0028").
e	0.50 BASIC		$\triangle$	THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10MM (.0039") AND	
L	0.50	0.60	0.70	~	0.25MM (0.0098") FROM THE LEAD TIP.
θ	0°	-	8°	8	LEAD COPLANARITY SHALL BE WITHIN 0.10mm (0.004") AS MEASURED FROM THE SEATING PLANE.
R	0.08	-	0.20		DIMENSION "e" IS MEASURED AT THE CENTERLINE OF THE LEADS.
N	48				

3355 \ 16-038.10c

\* For reference only. BSC is an ANSI standard for Basic Space Centering.

### **DOCUMENT TITLE**

**SEMICONDUCTOR** 

16 Megabit (2M x 8-Bit / 1M x 16-Bit), CMOS 3.0 Volt-Only Boot Sector Flash Memory

#### **REVISION HISTORY**

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0.0	Datasheet Creation

**USTIN** 

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